

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination SMED, OLE FALK	
		Examiner Tan Le	Art Unit 3632	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,695,270	02-2004	Smed, Ole Falk	248/278.1
X	B	US-6,400,560	06-2002	Chian, Yue-Hui	361/681
X	C	US-6,702,604	03-2004	Moscovitch, Jerry	439/374
X	D	US-5,026,016	06-1991	Lisowski, Walter E.	248/314
X	E	US-6,409,475	06-2002	Ho, Chan Hsiang	416/63
X	F	US-5,584,105	12-1996	Krauss, Mark J.	24/614
X	G	US-6,435,617	08-2002	McNair, Curtis G.	297/397
X	H	US-6,254,302	07-2001	Kraus, Willibald	403/326
X	I	US-4,088,848	05-1978	Weed, Howard S.	248/314
X	J	US-5,850,954	12-1998	Dong-Joo, Kim	224/197
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
X	N	WO 01/35796	05-2001	WIPO	Hibbert	n/a
X	O	EP 1139003	04-2001	EP	Thomas	n/a
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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